

Electromagnetic Emission

FCC MEASUREMENT REPORT

CERTIFICATION OF COMPLIANCE

FCC Part 15 Certification Measurement

PRODUCT : Scanner
MODEL/TYPE NO : MIS200BE / NONE
FCC ID : YUR-MIS200BE
MULTIPLE MODEL : -
BRAND NAME : -
APPLICANT : WITEK SYSTEM INC.
5 FL., Woochang B/D, 1218 Gaepo-dong,
Gangnam-gu, Seoul, Korea
Attn.: Sang Hyun Lee / Assistant Manager
MANUFACTURER : WITEK SYSTEM INC.
5 FL., Woochang B/D, 1218 Gaepo-dong,
Gangnam-gu, Seoul, Korea
FCC CLASSIFICATION : Class B Personal computers and peripherals
RULE PART(S) : FCC Part 15 Subpart B
TEST PROCEDURE : ANSI C63.4-2003
TEST REPORT No. : ETLE101123.0678
DATES OF TEST : December 22, 2010 to December 27, 2010
REPORT ISSUE DATE : December 30, 2010
TEST LABORATORY : ETL Inc. (FCC Designation Number: KR0022)

This Scanner, Model MIS200BE has been tested in accordance with the measurement procedures specified in ANSI C63.4-2003 at the ETL/EMC Test Laboratory and has been shown to be complied with the electromagnetic radiated emission limits specified in FCC Rule Part15 Subpart B:

I attest to the accuracy of data. All measurement herein was performed by me or was made under my supervision and is correct to the best of my knowledge and belief. I assume full responsibility for the completeness of these measurements and vouch for the qualifications of all persons taking them.

The results of testing in this report apply to the product/system which was tested only. Other similar equipment will not necessarily produce the same results due to production tolerance and measurement uncertainties.



Yo Han, Park / Chief Engineer

ETL Inc.

#371-51, Gasan-dong, Geumcheon-gu, Seoul, 153-803, Korea

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This report only responds to the tested sample and may not be reproduced, except in full, without written approval of the ETL Inc.

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FCC MEASUREMENT REPORT

Scope – Measurement and determination of electromagnetic emission(EME) of radio frequency devices including intentional radiators and/or unintentional radiators for compliance with the technical rules and regulations of the U.S Federal Communications Commission(FCC)

General Information

Applicant Name : WITEK SYSTEM INC.

Address : 5 FL., Woochang B/D, 1218 Gaepo-dong,
Gangnam-gu, Seoul, Korea

Attention : Sang Hyun Lee / Assistant Manager

- **EUT Type :** Scanner
- **Model Number :** MIS200BE
- **S/N :** NONE
- **Frequency Range :** X-tal → 24.000 MHz
- **Rule Part(s) :** FCC Part 15 Subpart B
- **Test Procedure :** ANSI C63.4-2003
- **FCC Classification :** Class B Personal computers and peripherals
- **Dates of Tests :** December 22, 2010 to December 27, 2010
- **Place of Tests :** ETL Inc. Testing Lab. (FCC Designation Number : KR0022)

Radiated Emission test;
#499-1, Sagot-ri, Seosin-myeon, Hwaseong-si,
Gyeonggi-do, 445-882, Korea

Conducted Emission test;
ETL Inc. Testing Lab. (FCC Designation Number : KR0022)
371-51, Gasan-dong, Geumcheon-gu, Seoul, 153-803, Korea
- **Test Report No. :** ETLE101123.0678

1. INTRODUCTION

The measurement tests for radiated and conducted emission test were conducted at the ETL Inc. The site is constructed in conformance with the requirements of the ANSI C63.4-2003 and CISPR Publication 16. The ETL has site descriptions on file with the FCC for 3 m and 10 m site configurations. Detailed description of test facility was found to be in compliance with the requirements of Section 2.948 FCC Rules according to the ANSI C63.4-2003 and registered to the Federal Communications Commission (FCC Designation Number : KR0022).

The measurement procedure described in American National Standard for Method of Measurement of Radio-Noise Emission from Low-Voltage Electrical and Electronic Equipment in the Range of 9 kHz to 40 GHz (ANSI C63.4-2003) was used in determining radiated and conducted emissions from the WITEK SYSTEM INC., Model: MIS200BE.

2. PRODUCT INFORMATION

2.1 Equipment Description

The Equipment Under Test (EUT) is the Scanner (model: MIS200BE).

2.2 General Specification

Item	Specification
Scan source	Single sided Contact Image Sensing
Scan size	Width: up to 104 mm (lottery application: 82.55 mm)
	Length: up to 290 mm
Scanning Resolution	200 dpi
Scanning Speed	Max. 400 mm/sec at B/W, 256 Gray
Out put Format	1 bit (b/w), 4 bit (16 gray), 8 bit (256 gray)
Image format	BMP, JPG, TIF and raw image data
Interface	USB 2.0 & 1.1 (Windows, Linux driver support)
Paper thickness	0.1 mm ~ 0.2 mm
Power	+24 VDC/2.5 A
MTBF	50 000 hours (CIS only)
Dimension	162.0 mm (W) x 110.5 mm(H) x 155.0 mm(D)
Weight	1.7 kg
Temperature	-20 ℃ ~ +60 ℃
Humidity	10 %R.H. ~ 90 %R.H. non-condensing
Scanner SDK	API Programming support(library files)
	Linux/window available
Option	Thermal Brander Dual CIS Sensor (Dual Scan) Shade free Scan Image processing Library OMR Library Barcode Recognition Library UV Sensor light for counterfeit detection

3. DESCRIPTION OF TESTS

3.1 Conducted Emission Measurement

Conducted emissions measurements were made in accordance with section 11, "Measurement of Information Technology Equipment" of ANSI C63.4-2003. The measurements were performed over the frequency range of 0.15 MHz to 30 MHz using a 50 Ω / 50uH LISN as the input transducer to a Spectrum Analyzer or a Test Receiver. The measurements were made with the detector set for "Peak" amplitude within a bandwidth of 9 kHz or for "quasi-peak" within a bandwidth of 9 kHz.

The line-conducted emission test is conducted inside a shielded anechoic chamber room with 1 m x 1.5 m x 0.8 m wooden table which is placed 40 cm away from the vertical wall and 1.5 m away from the side wall of the chamber room. Two LISN are bonded to the shielded room. The EUT is powered from the LISN and the support equipment is powered from the other LISN. Power to the LISNs are filtered by a noise cut power line filters. All electrical cables are shielded by braided tinned steel tubing with inner ϕ 1.2 cm. If the EUT is a DC-powered device, power will be derived from the source power supply it normally will be powered from and these supply lines will be connected to the LISN. Non-inductive bundling to a 1 m length shortened all interconnecting cables more than 1 m. Sufficient time for the EUT, support equipment, and test equipment was allowed in order for them to warm up to their normal operating condition. The RF output of the LISN was connected to the EMI Test Receiver to determine the frequency producing the maximum emission from the EUT. The frequency producing the maximum level was reexamined using to set Quasi-Peak mode by manual, after scanned by automatic Peak mode from 0.15 MHz to 30 MHz. The bandwidth of the spectrum analyzer was set to 9 kHz. The EUT, support equipment, and interconnecting cables were arranged and manipulated to maximize each emission.

Photographs of the worst-case emission can be seen in photographs of conducted emission test setup in Appendix B.

3.2 Radiated Emission Measurement

Radiated emission measurements were made in accordance with section 11, "Measurement of Information Technology Equipment" of ANSI C63.4-2003. The measurements were performed over the frequency range of 30 MHz to 1 GHz using antenna as the input transducer to a spectrum analyzer or a field intensity meter. The measurements were made with the detector set for "Quasi-peak" within a bandwidth of 120 kHz.

Preliminary measurements were made at 3 m using broadband antennas, and spectrum analyzer to determine the frequency producing the maximum emission in shielded room. Appropriate precaution was taken to ensure that all emission from the EUT were maximized and investigated. The system configuration, mode of operation, turntable azimuth and height with respect to the antenna were noted for each frequency found. The spectrum was scanned from 30 MHz to 1 000 MHz using Log-Bicon antenna. Above 1 GHz, linearly polarized double ridge horn antennas were used. Final measurements were made open site at 10 m. The test equipment was placed on a wooden turn-table. Sufficient time for the EUT, support equipment, and test equipment was allowed in order for them to warm up to their normal operating condition. Each frequency found during pre-scan measurements was re-examined by manual. The detector function was set to CISPR Quasi-peak mode and the bandwidth of the receiver was set to 120 kHz or 1MHz depending on the frequency of type of signal. The EUT, support equipment and interconnecting cables were re-configured to the set-up producing the maximum emission for the frequency and were placed on top of a 0.8 m high nonmetallic 1 m x 1.5 m table. The EUT, support equipment, and interconnecting cables were re-arranged and manipulated to maximize each emission. The turntable containing the system was rotated; the antenna height was varied 1 m to 4 m and stopped at the azimuth or height producing the maximum emission. Each emission was maximized by: varying the mode of operation to the EUT and/or support equipment and changing the polarity of the antenna, whichever determined the worst-case emission.

Photographs of the worst-case emission can be seen in Photographs of the worst-case emission test setup can be seen in Appendix B.

4. TEST CONDITION

4.1 Test Configuration

The device was configured for testing in a typical fashion (as a customer would normally use it). During the tests, the EUT and the supported equipments were installed to meet FCC requirement and operated in a manner and which tends to maximize its emission level in a typical application.

4.2 EUT operation

- Stand by mode
- During the test, EUT was the continuous scanning mode

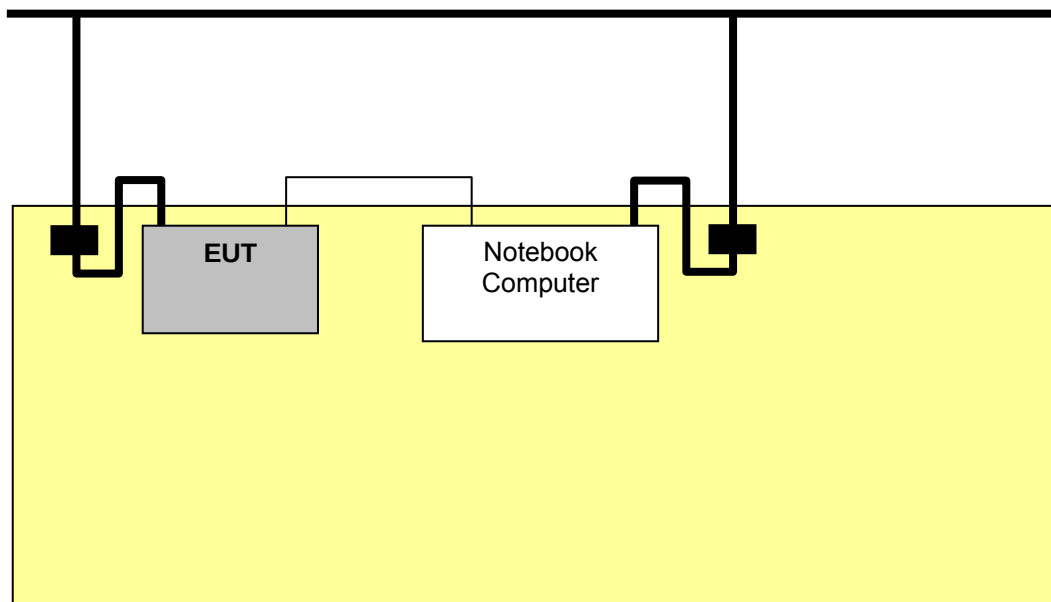
4.3 Support Equipment Used

Description	Model Name	Serial No.	Manufacturer
Adapter (for EUT)	LSE9901B2460	A30809011073	Suzhou Li Shin Electronic Co., Ltd.
Notebook Computer	6730b	CNU8390GPZ	Hewlett-Packard Company
Adapter (for Notebook Computer)	Series PPP014H-S	F1-08070401760A	Hipro Electronics(Suzhou) Co., Ltd.

4.4 Type of Cables Used

Device from	Device to	Type of I/O port	Length[m]	Type of shield
EUT	Notebook Computer	USB	1.5	Shielded
EUT	Adapter	DC Input	1.2	Shielded
Notebook Computer	Adapter	DC Input	1.2	Shielded

4.5 The setup drawing(s)



_____ : Data Line
 _____ : Power Line
 ■ : Adapter

5. TEST RESULTS

5.1 Summary of Test Results

The measurement results were obtained with the EUT tested in the conditions described in this report. Detailed measurement data and plots showing the maximum emission of the EUT are reported.

FCC Rule	Measurement Required	Result
15.107(a)	Conducted Emission Measurement	Passed by 13.57 dB
15.109(g)	Radiated Emission Measurement	Passed by 3.10 dB

The data collected shows that the **WITEK SYSTEM INC. / Scanner / MIS200BE** complied with technical requirements of above rules part 15.107(a) and 15.109(g) Class B Limits and CISPR Publication 22.

The equipment is not modified anything, mechanical or circuits to improve EMI status during a measurement. No EMI suppression device(s) was added and/or modified during testing.

5.2 Conducted Emissions Measurement

5.2.1 Conducted Emissions Data

EUT	Scanner / MIS200BE (S/N: N/A)
Limit apply to	FCC Part 15.107(a) Class B
Test Date	December 22, 2010
Operating Condition	Continuous scanning mode
Result	Passed by 13.57 dB

Conducted Emission Test Data

The following table shows the highest levels of conducted emissions on both polarizations of hot and neutral line.
Detector mode: CISPR Quasi-Peak mode (6 dB Bandwidth: 9 kHz)

Frequency [MHz]	Result [dB(μ V)]		Phase (*H/**N)	Limit [dB(μ V)]		Margin [dB]	
	Quasi-peak	Average		Quasi-peak	Average	Quasi-peak	Average
0.169	45.56	26.91	H	65.01	55.01	19.45	28.10
0.204	43.54	21.99	H	63.45	53.45	19.91	31.46
0.277	38.36	21.93	H	60.91	50.91	22.55	28.98
4.550	34.59	16.97	H	56.00	46.00	21.41	29.03
4.745	34.49	18.67	H	56.00	46.00	21.51	27.33
4.910	36.02	18.94	H	56.00	46.00	19.98	27.06
18.340	45.22	36.43	N	60.00	50.00	14.78	13.57
23.140	42.84	34.03	N	60.00	50.00	17.16	15.97
25.240	42.20	29.63	H	60.00	50.00	17.80	20.37

NOTES:

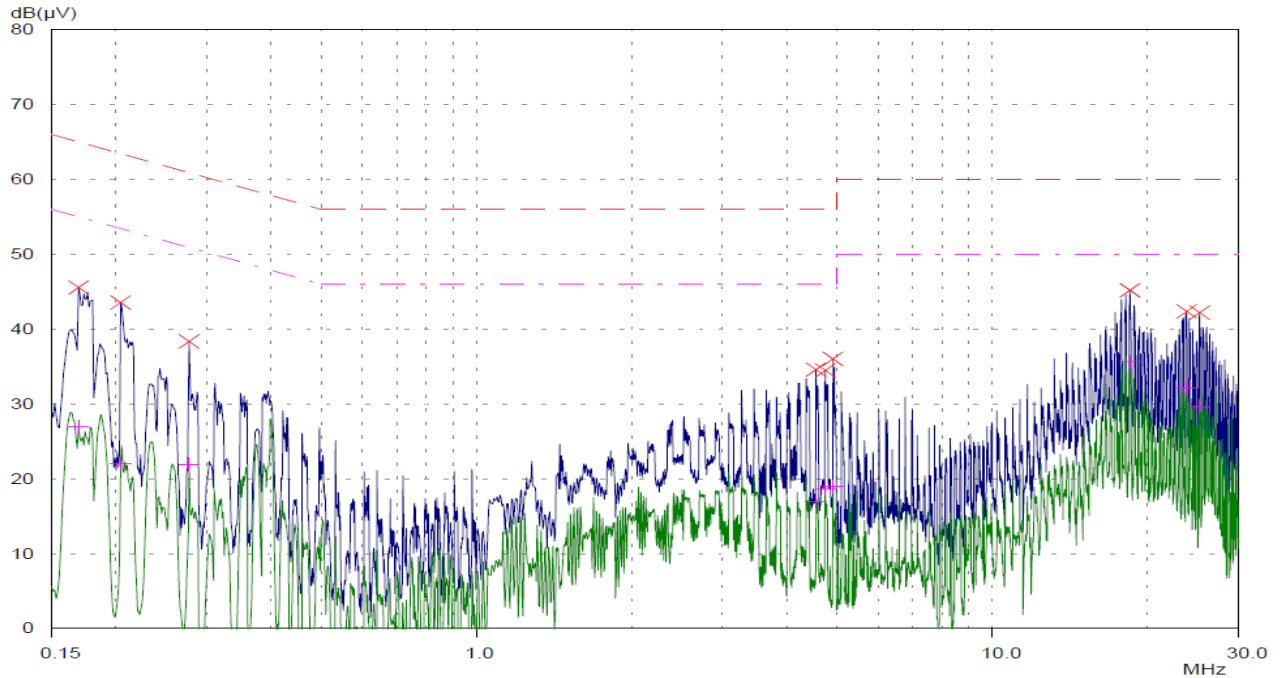
- * H: HOT Line , **N: Neutral Line
- Margin value = Limit - Result
- Measurement were performed at the AC Power Inlet in the frequency band of 150 kHz ~ 30 MHz according to the FCC Part 15.107(a) Class B.
- If the average limit is met when using a Quasi-peak detector receiver, the EUT shall be deemed to meet both limits and measurement with the average detector receiver is unnecessary.



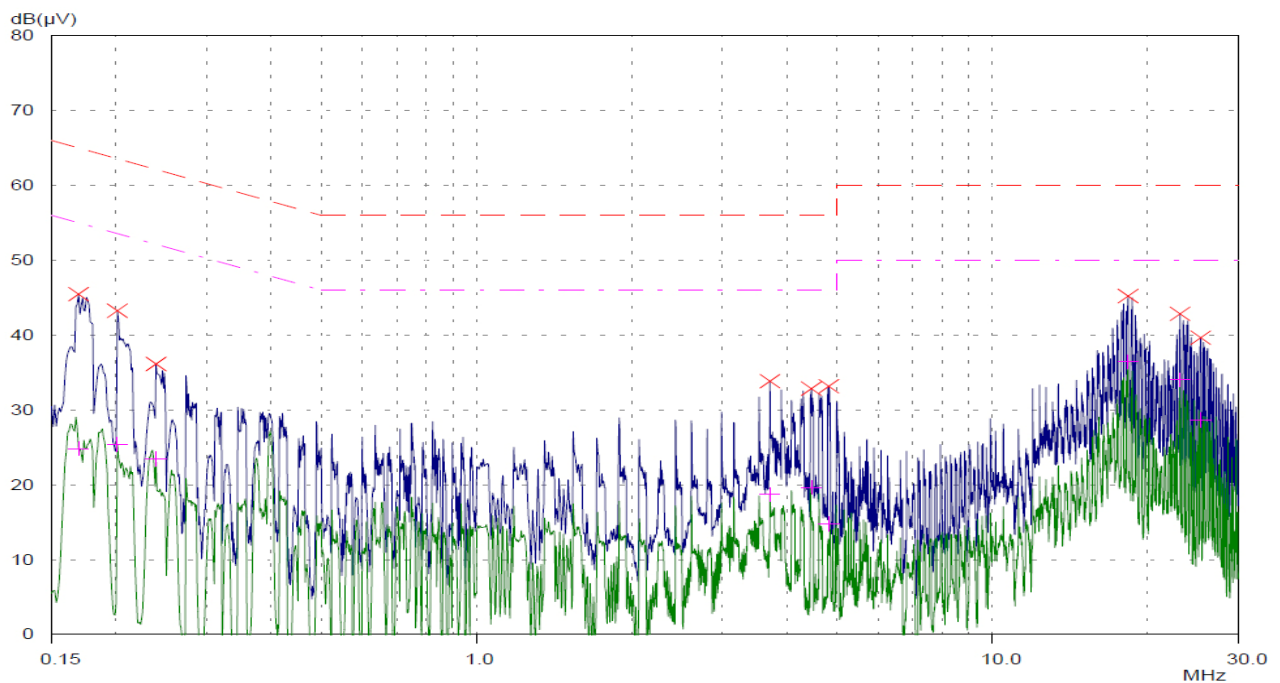
Test Engineer: Jae Young, Kwon

Line: HOT Line

Limit : --- Quasi-Peak
- - - Average



Line: Neutral Line



Quasi-peak x Average +

5.3 Radiated Emissions Measurement

5.3.1 Radiated Emissions Data

EUT	Scanner / MIS200BE (S/N: N/A)
Limit apply to	FCC Part 15.109(g) (CISPR 22 Class B)
Test Date	December 27, 2010
Operating Condition	Continuous scanning mode
Result	Passed by 3.10 dB

Radiated Emission Test Data

The following table shows the highest levels of radiated emissions on both polarizations of horizontal and vertical.
Detector mode: CISPR Quasi-Peak mode (6 dB Bandwidth: 120 kHz)

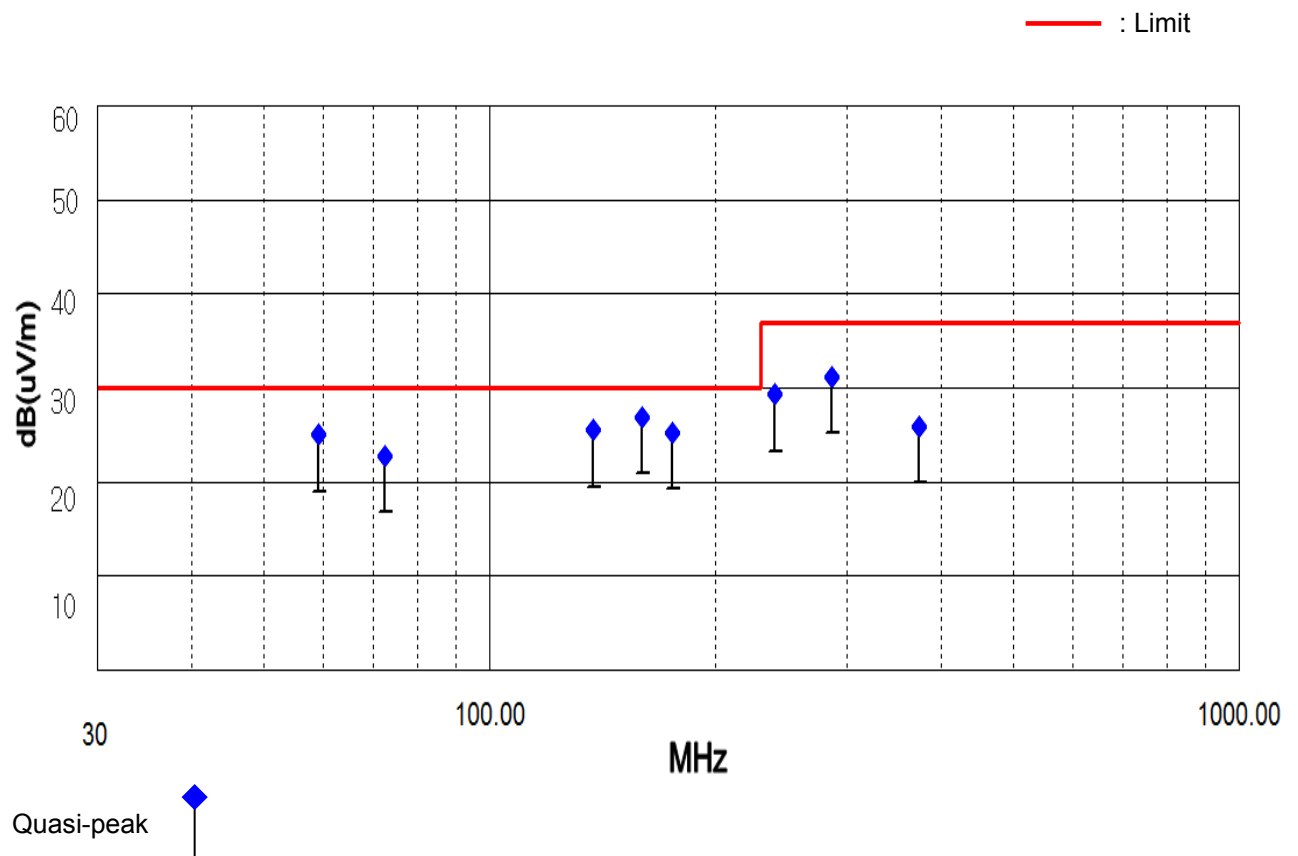
Frequency [MHz]	Reading [dB(μ V)]	Polarization (*H/**V)	Ant. Factor [dB/m]	Cable Loss [dB(μ V)]	Result [dB(μ V/m)]	Limit [dB(μ V/m)]	Margin [dB]
59.03	11.85	V	11.86	1.29	25.00	30.00	5.00
72.53	11.62	V	9.74	1.44	22.80	30.00	7.20
137.33	10.86	V	12.27	2.37	25.50	30.00	4.50
159.60	11.14	V	13.19	2.57	26.90	30.00	3.10
175.13	10.79	V	11.77	2.74	25.30	30.00	4.70
239.93	15.22	H	10.93	3.15	29.30	37.00	7.70
286.50	15.17	H	12.46	3.57	31.20	37.00	5.80
373.50	6.88	H	14.66	4.36	25.90	37.00	11.10

NOTES:

- * H : Horizontal polarization , ** V : Vertical polarization
- Result = Reading + Antenna factor + Cable loss
- Margin value = Limit - Result
- The measurement was performed for the frequency range 30 MHz ~ 1 000 MHz according to the FCC Part 15.109(g) and CISPR 22 Class B.



Test Engineer: Jae Young, Kwon



6. SAMPLE CALCULATION

Sample Field Strength Calculation

The field strength is calculated by adding the Antenna Factor and Cable Factor.
The basic equation with a sample calculation is as follows:

$$FS = RA + AF + CF$$

Where FS = Field Strength

RA = Receiver Amplitude

AF = Antenna Factor

CF = Cable Attenuation Factor

$$dB(\mu V) = 20 \log_{10} (\mu V)$$

$$dB\mu V = dBm + 107$$

Example : @ 159.60 MHz

$$\text{Class B Limit} = 30.00 \text{ dB}(\mu V/m) \text{ (CISPR 22 Class B)}$$

$$\text{Reading} = 11.14 \text{ dB}(\mu V)$$

$$\text{Antenna Factor + Cable Loss} = 13.19 + 2.57 = 15.76 \text{ dB}(\mu V/m)$$

$$\text{Total} = 26.90 \text{ dB}(\mu V/m)$$

$$\text{Margin} = 30.00 - 26.90 = 3.10 \text{ dB}$$

$$= 3.10 \text{ dB below Limit}$$

7. List of test equipments used for measurements

	Test Equipment	Model	Mfg.	Serial No.	Cal. Due Date
☒	EMI TEST Receiver	ESVS 10	R & S	835165/001	11.04.02
☒	EMI TEST Receiver	ESHS 30	R & S	840190/002	11.04.02
☒	LISN	3825/2	EMCO	9006-1669	11.09.16
☒	LISN	3816-2	EMCO	1001	11.09.17
☒	LogBicon Antenna	VULB9160	Schwarzbeck	3082	12.02.22
☒	Turn-Table	MFT-120S	Max-Full Antenna Corp	-	N/A
☒	Antenna Master	MFA-440E	Max-Full Antenna Corp	-	N/A